Search Notes

Applic	ation/Control	No.

Applicant(s)/Patent under Reexamination
SHIRAISHI ET AL.

10/541,336

Art Unit

Examiner

Quang T. Van

3742

SEARCHED						
Class	Subclass	Date	Examiner			
373	93,91,92 88,95 51,105	8/22/05	QV			
428	408		1			
266	46					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Eastsearch	8/22/08	æv	
Eastsearch Inventor check	8/22/06	ar	
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